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APPLICATION NO. FILING DATE		IG DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/661,429	09/13/2000		Simon Fafard	99388-US	8408
23553	7590	08/14/2003			
MARKS & (			EXAMINER		
P.O. BOX 957 STATION B		7	NGUYEN, JOSEPH H		
OTTAWA, ON KIP 5S7 CANADA				ART UNIT	PAPER NUMBER
				2815	
				DATE MAILED: 08/14/2003	

Please find below and/or attached an Office communication concerning this application or proceeding.

, <b>1</b>				lh				
		Application No.	Applicant(s)					
		09/661,429	FAFARD, SIMON					
` Offic Action Summary		Examiner	Art Unit					
		Joseph Nguyen	2815					
<i>T</i> Period for R	he MAILING DATE of this communication eply	appears on the cover sheet	with the correspondence addre	ISS				
THE MA - Extension after SIX - If the peri - If NO peri - Failure to - Any reply	TENED STATUTORY PERIOD FOR RE LING DATE OF THIS COMMUNICATION IN THE PROVISIONS of 37 CFI (6) MONTHS from the mailing date of this communication of for reply specified above is less than thirty (30) days, a confort of the second for reply is specified above, the maximum statutory per reply within the set or extended period for reply will, by streceived by the Office later than three months after the material term adjustment. See 37 CFR 1.704(b).	NN. R 1.136(a). In no event, however, may I. I reply within the statutory minimum of I riod will apply and will expire SIX (6) No I atute, cause the application to become	y a reply be timely filed thirly (30) days will be considered timely. MONTHS from the mailing date of this comme	iunication.				
1)⊠ R	esponsive to communication(s) filed on	<u>11 June 2003</u> .						
2a) <u></u> ⊤	his action is <b>FINAL</b> . 2b)⊠	This action is non-final.						
cl	ince this application is in condition for all osed in accordance with the practice under the condition in the practice under the conditions are the conditions.			nerits is				
Disposition								
•	aim(s) <u>1-20</u> is/are pending in the applica							
	Of the above claim(s) is/are with	drawn from consideration.						
·	aim(s) is/are allowed.							
·	aim(s) <u>1-20</u> is/are rejected.			•				
	aim(s) is/are objected to.	ad/ar alaction requirement						
Application	aim(s) are subject to restriction ar	id/or election requirement.						
	e specification is objected to by the Exan	niner.						
•	drawing(s) filed on is/are: a)⊠ a		by the Examiner.					
•	pplicant may not request that any objection t							
11)⊠ The proposed drawing correction filed on <u>03 December 2002</u> is: a)⊠ approved b) disapproved by the Examiner.								
If	approved, corrected drawings are required i	n reply to this Office action.						
12) 🗌 The	oath or declaration is objected to by the	e Examiner.						
Priority und	er 35 U.S.C. §§ 119 and 120							
13) 🗌 Ad	knowledgment is made of a claim for for	reign priority under 35 U.S.	C. § 119(a)-(d) or (f).					
a)	All b)☐ Some * c)☐ None of:							
1.[	Certified copies of the priority document	nents have been received.						
2.[	Certified copies of the priority document	nents have been received i	n Application No					
	<ul> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>							
	nowledgment is made of a claim for dom	•		onlication)				
,	The translation of the foreign language			>pout.o/.				
, –	nowledgment is made of a claim for don	•						
Attachment(s)								
2) Notice of	References Cited (PTO-892) Draftsperson's Patent Drawing Review (PTO-948 on Disclosure Statement(s) (PTO-1449) Paper No	5) Notice	ew Summary (PTO-413) Paper No(s). of Informal Patent Application (PTO-1					

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## **DETAILED ACTION**

## Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-5 are rejected under 35 U.S.C. 103(a) as being unpatentable over Cook in view of Petroff et al.

Regarding claim 1, Cook discloses on figure 2 substantially all the structure set forth in the claimed invention except said self assembled quantum structures being selected from the group consisting of quantum dots and quantum wires. However, Petroff et al discloses on figure G said self assembled quantum structures 108 being selected from the group consisting of quantum dots and quantum wires. In view of such teaching, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Cook by having said self assembled quantum structures being selected from the group consisting of quantum dots and quantum wires for the purpose of providing a reliable semiconductor laser device.

Regarding claims 2-5, Cook and Petroff et al together disclose all the structure set forth in claims 2-5.

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Claims 6-7 are rejected under 35 U.S.C. 103(a) as being unpatentable over Cook and Petroff et al as applied to claim 5 above, and further in view of Romano et al.

Regarding claim 6, Cook and Petroff et al disclose substantially all the structure set forth in the claimed invention except a wetting layer underneath the low dimensional structures. However, Romano et al discloses on figure 2 a wetting layer 220 underneath the low dimensional structures 250. In view of such teaching, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Cook and Petroff et al by having a wetting layer underneath the low dimensional structures for the purpose of promoting smooth, uniform overage of the substrate as taught by Romano et al (col. 4, lines 36-40).

Regarding claim 7, the claim limitation is functional language and therefore not given patentable weight.

Claims 8-20 are rejected under 35 U.S.C. 103(a) as being unpatentable over Cook and Petroff et al and Romano et al as applied to claim 7 above, and further in view of Sugiyama.

Regarding claim 8, Cook and Petroff et al and Romano et al disclose substantially all the structures set forth in the claimed invention except intermediate layers between the active region and the electron and hole emitting layers. However, Sugiyama discloses intermediate layers between the active region and the electron and hole emitting layers (col. 5, lines 4-15). In view of such teaching, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify

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Cook and Petroff et al and Romano et al by having intermediate layers between the active region and the electron and hole emitting layers for the purpose of improving the performance of a semiconductor laser.

Regarding claims 9-10, Cook and Petroff et al and Romano et al and Sugiyama disclose substantially all the structure set forth in the claimed invention except the laser diode consisting mainly of gallium, indium, aluminum, arsenic, nitrogen and phosphorous. However, it would have been obvious to one having ordinary skill in the art at the time the invention was made to modify Cook and Petroff et al and Romano et al and Sugiyama by having the laser diode consisting mainly of gallium, indium, aluminum, arsenic, nitrogen and phosphorous for the purpose of improving the performance of a semiconductor laser diode, since it has been held to be within the general skill of a worker in the art to select a known material on the basis of its suitability for the intended use as matter of obvious design choice. In re Leshin, 125 USPQ 416.

Regarding claims 11-16, Cook and Petroff et al and Romano et al and Sugiyama disclose substantially all the structure set forth in the claimed invention except the graded compositions of electron and hole emitting layers, active region and barrier layers. However, it would have been obvious to one having ordinary skill in the art at the time of the invention was made to modify Cook and Petroff et al and Romano et al and Sugiyama by having the graded compositions of electron and hole emitting layers, active region and barrier layers for the purpose of improving the performance of a semiconductor laser diode, since it has been held that discovering an optimum value of

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a result effective variable involves only routine skill in the art. In re Boesch, 617 F.2d

272, 205 USPQ 215 (CCPA 1980).

Regarding claims 17-20, Cook and Petroff et al and Romano et al and Sugiyama

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disclose substantially all the structure set forth in the claimed invention.

Response to Arguments

Applicant's arguments with respect to claims 1-20 have been considered but are

moot in view of the new ground(s) of rejection.

Conclusion

Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Joseph Nguyen whose telephone number is (703) 308-

1269. The examiner can normally be reached on Monday-Friday, 7:30 am- 4:30 pm

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Eddie Lee can be reached on (703) 308-1690. The fax phone numbers for

the organization where this application or proceeding is assigned is (703) 308-7382 for

regular communications.

Any inquiry of a general nature or relating to the status of this application or

proceeding should be directed to the receptionist whose telephone number is (703) 308-

0956.

JN

August 1, 2003

**FDDIF I FF** 

SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 2800